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MEASUREMENT REPORT FCC Report

Guangzhou Chenle Information Technology Co., LTD Applicant:

Address of Applicant: 1005A room, No. 89, Yanling Road, Tianhe District, Guangzhou, China

Guangzhou Chenle Information Technology Co., LTD Manufacturer:

1005A room, No. 89, Yanling Road, Tianhe District, Guangzhou, China Address of

Manufacturer:

Equipment Under Test (EUT):

Product: Tablet PC

V701S, V80, V96, V80 SE, V820W DUAL OS, OBOOK10 SE, V891W CH, Model No.:

V80Plus, OBOOK10 DualOS, OBOOK10 Pro, OBOOK10 plus, OBOOK11 Plus,

OBOOK11 Pro, OBOOK12, V801S, V820W CH DUALOS,

V919AIR CH DUALOS, V975S, OBOOK11 DUALOS, OBOOK11.

Test Model No.: OBOOK10 DualOS

Brand Name: ONDA

FCC ID: 2AIXEOBOOK10 Standards: 47 CFR Part 15B

Date of Test: 2016-06-02 to 2016-06-07

Date of Issue: 2016-06-07

PASS* **Test Result:**

(Owen Zhou)

^{*} In the configuration tested, the EUT complied with the standards specified above.





Revision History Of Report

Report No.	Version	Description	Issue Date
CQASZ160501323E-01	Rev.01	Initial report	2016-06-07



2 Test Summary

Test Item	Test Requirement	Test method	Result
Radiated Emission	47 CFR Part 15B	ANSI C63.4 (2014)	PASS
Conducted Emission	47 OFD Dow 45D	ANCLOCO 4 (2044)	DACC
(150KHz to 30MHz)	47 CFR Part 15B	ANSI C63.4 (2014)	PASS



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4 General Information

4.1 Client Information

Applicant:	Guangzhou Chenle Information Technology Co., LTD
Address of Applicant:	1005A room , No. 89, Yanling Road, Tianhe District, Guangzhou, China
Manufacturer:	Guangzhou Chenle Information Technology Co., LTD
Address of Manufacturer:	1005A room , No. 89, Yanling Road, Tianhe District, Guangzhou, China

4.2 General Description of EUT

_		i			
Product Name:	Tablet PC				
Model No.:	V701S, V80, V96, V80 SE, V820W DUAL OS, OBOOK10 SE, V891W CH, V80Plus, OBOOK10 DualOS, OBOOK10 Pro, OBOOK10 plus, OBOOK11 Plus, OBOOK11 Pro, OBOOK12, V801S, V820W CH DUALOS, V919AIR CH DUALOS, V975S, OBOOK11 DUALOS, OBOOK11.				
Test Model No.:	OBOOK10 DualOS				
Trade Mark:	ONDA				
Hardware Version:	V02				
Software Version:	V1.0				
Highest Operating Frequency (CPU):	1.84GHz				
Sample Type:	portable production				
Power Supply:	Adapter:	Mode: TPA-915200CU			
		Input: AC100-240V 50/60Hz 0.4A			
	Output: DC5.0V 2.0A				
	EUT Power Supply:	DC5.0V			
	Rechargeable li-ion battery DC3.8V, 6000mAh				
Test Voltage:	AC120V 60Hz				

Note:

1. Model No.: V701S, V80, V96, V80 SE, V820W DUAL OS, OBOOK10 SE, V891W CH, V80Plus, OBOOK10 DualOS, OBOOK10 Pro, OBOOK10 plus, OBOOK11 Plus, OBOOK11 Pro, OBOOK12, V801S, V820W CH DUALOS, V919AIR CH DUALOS, V975S, OBOOK11 DUALOS, OBOOK11.

Only the model OBOOK10 DualOS was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, with difference being color of appearance, pack and model name.

2. The fully-charged li-ion battery is used for testing.



4.3 Test Environment

Operating Environment:				
Temperature:	24.0 °C			
Humidity:	52 % RH			
Atmospheric Pressure:	1008 mbar			

4.4 Description of Support Units

The EUT has been tested with associated equipment below.

Description	Manufacturer	Model No.
PC	Lenovo	Lenovo ideapad 100-14IBY
Mouse	Lenovo	KM040
Adapter(PC)	Lenovo	PA-1450-55LN

4.5 Test Location

All tests were performed at:

Shenzhen CTL Testing Technology Co., Ltd., Shenzhen EMC Laboratory,

1/F.-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, Guangdong, China

4.6 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate.

The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities.

The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025.

Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

Test	Range	Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10dB	(1)
Radiated Emission	1~12.75GHz	4.32dB	(1)
Conducted Disturbance	0.15~30MHz	3.20dB	(1)

(1)This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



4.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 970318

Shenzhen CTL Testing Technology Co., Ltd. has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 970318

4.8 Deviation from Standards

None.

4.9 Abnormalities from Standard Conditions

None.

4.10 Other Information Requested by the Customer

None.



4.11 Equipment List

Test Equipment Bilog Antenna	Manufacturer Sunol Sciences	Model No.	Serial No.	Calibration Due Date
·	Sunol Sciences	Model No.	Serial No.	Due Date
Bilog Antenna				1
Bilog Antenna				
	Corp.	JB1	A061713	2017/06/01
	ROHDE &			
EMI Test Receiver	SCHWARZ	ESCI3	103710	2017/06/01
Spectrum Analyzer	Agilent	E4407B	MY45108355	2017/05/20
		Controller		
Controller	EM Electronics	EM 1000	N/A	2017/05/20
	Sunol Sciences			
Horn Antenna	Corp.	DRH-118	A062013	2017/05/18
Spectrum Analyzer	R&S	FSU	MY41440676	2017/05/18
LISN	R&S	ENV216	101316	2017/06/01
LISN	SCHWARZBECK	NSLK8127	8127687	2017/06/01
Microwave				
Preamplifier	HP	8349B	3155A00882	2017/05/18
Preamplifier	HP	8447D	3113A07663	2017/05/18
·				2017/06/01
Meter	Gangxing	CTH-608	02	2017/05/19
Climate Chamber	ESPEC			2017/05/19
				2017/05/19
·				2017/05/19
	Spectrum Analyzer Controller Horn Antenna Spectrum Analyzer LISN LISN Microwave Preamplifier Preamplifier Transient Limiter Temperature/Humidity Meter	Spectrum Analyzer Controller EM Electronics Sunol Sciences Corp. Spectrum Analyzer R&S LISN R&S LISN SCHWARZBECK Microwave Preamplifier HP Transient Limiter Com-Power Temperature/Humidity Meter Climate Chamber RF Cable(0-1GHz) HM Electronics Sunol Sciences Corp. R&S SCHWARZBECK Marcowave Com-Power Femperature/Humidity HP Cangxing ESPEC HUBER+SUHNER	Spectrum Analyzer Agilent E4407B Controller EM Electronics EM 1000 Sunol Sciences Horn Antenna Corp. DRH-118 Spectrum Analyzer R&S FSU LISN R&S ENV216 LISN SCHWARZBECK NSLK8127 Microwave Preamplifier HP 8349B Preamplifier HP 8447D Transient Limiter Com-Power LIT-153 Temperature/Humidity Meter Gangxing CTH-608 Climate Chamber ESPEC EL-10KA RF Cable(0-1GHz) HUBER+SUHNER RG174	Spectrum Analyzer

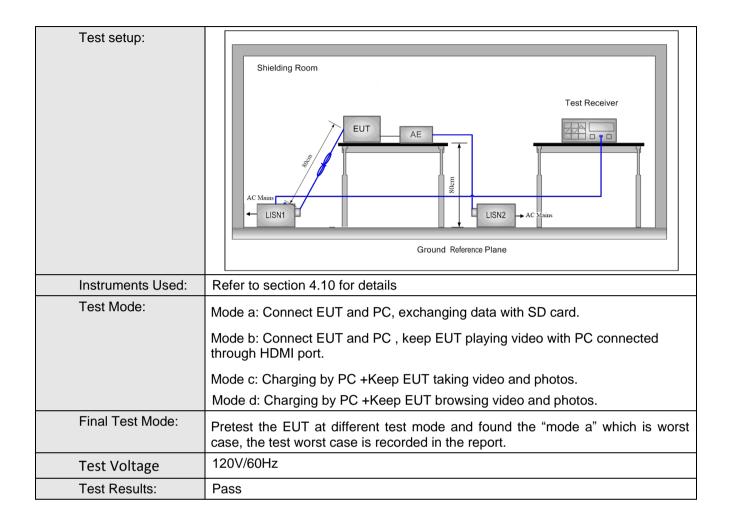


5 Test results and Measurement Data

5.1 Conducted Emissions

Test Requirement:	47 CFR Part 15B				
Test Method:	ANSI C63.4: 2014				
Test Frequency Range:	150kHz to 30MHz				
Limit:	Francisco de (MILI-)	Limit (dBuV)			
	Frequency range (MHz)	Quasi-peak	Average		
	0.15-0.5	66 to 56*	56 to 46*		
	0.5-5	56	46		
	5-30	60	50		
	* Decreases with the logarithm	n of the frequency.			
Test Procedure:	0.15-0.5 66 to 56* 56 to 46* 0.5-5 56 46				





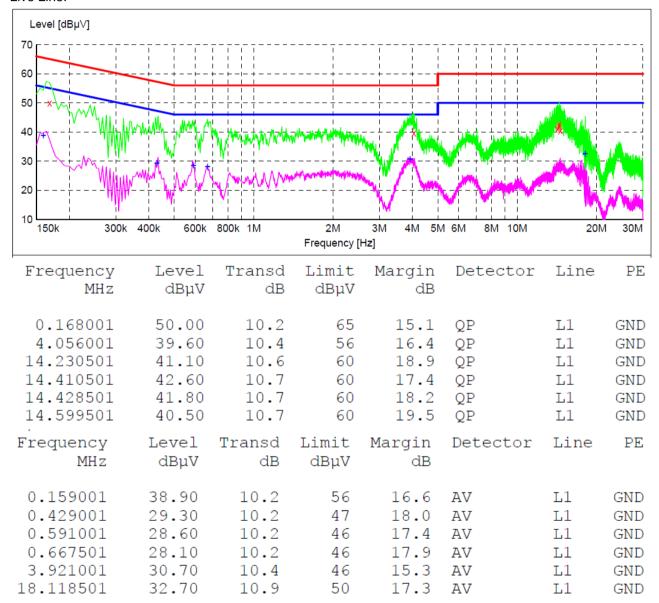


Measurement Data

An initial pre-scan was performed on the live and neutral lines with peak detector.

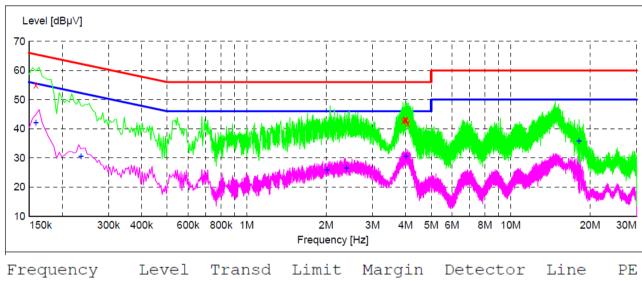
Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.

Live Line:





Neutral Line:



Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.159001 3.930001 3.975001 4.002001 4.020001 4.078501	55.00 42.70 43.10 43.40 42.90 41.90	10.2 10.4 10.4 10.4 10.4	66 56 56 56 56	10.5 13.3 12.9 12.6 13.1 14.1	QP QP QP QP QP QP	N N N N N	GND GND GND GND GND GND
Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
MHz	dΒμV	dB	dΒμV	dB			
MHz 0.159001	dBμV 42.00	dB 10.2	dBμV 56	dB 13.5	Detector AV	N	PE GND
MHz	dΒμV	dB	dΒμV	dB			
MHz 0.159001	dBμV 42.00	dB 10.2	dBμV 56	dB 13.5	AV	N	GND
MHz 0.159001 0.235501	dBµV 42.00 30.60	dB 10.2 10.2	dВµV 56 52	dB 13.5 21.7	AV AV	N N	GND GND
MHz 0.159001 0.235501 2.013001	dBµV 42.00 30.60 26.00	dB 10.2 10.2 10.4	dBμV 56 52 46	dB 13.5 21.7 20.0	AV AV AV	N N N	GND GND GND

Notes:

- 1. The following Quasi-Peak and Average measurements were performed on the EUT,
- 2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.





5.2 Radiated Emission

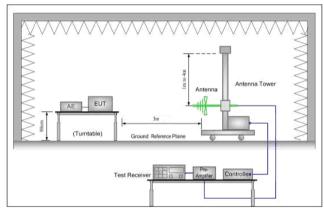
Test Requirement:	47	47 CFR Part 15B						
Test Method:	ΙA	ANSI C63.4: 2014						
Test Site:	М	Measurement Distance: 3m (Semi-Anechoic Chamber)						
Receiver Setup:		Frequency Detector		RBW	VBW	Remark		
		30MHz-1GHz	Quasi-peal	k	100kHz	300kHz	Quasi-peak Value	
		Above 1GHz	Peak		1MHz	3MHz	Peak Value	
Limit:		Freque	ency	Lir	mit (dBuV/	/m @3m)	Remark	
		30MHz-8	88MHz		40.0)	Quasi-peak Value	
		88MHz-2	16MHz		43.5	5	Quasi-peak Value	1
		216MHz-9	60MHz		46.0)	Quasi-peak Value	1
		960MHz	-1GHz		54.0)	Quasi-peak Value	1
		Above 1	ICH-		54.0)	Average Value	
		Above	10112		74.0)	Peak Value	ı
	No	ote:			T			
		Highest frequence	cy generated	l or				
		used in the devi	ce or on whi	ch	Upper fr	equency o	of measurement Ran	ge
		the device oper	rates or tune	s		(1	MHz)	
		(МН	lz)		30			
		Below	1.705					
		1.705 t	o 108		1000			
		108 to	500		2000			
		500 to	1000		5000			
		Above	1000		5th harmonic of the highest frequency or			or
					40GHz, whichever is lower			
Test Procedure:	 a. 1) Below 1G: The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower. 2) Above 1G: The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. Note: For the radiated emission test above 1GHz: Place the measurement antenna away from each area of the EUT determined 							
		to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The						



measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

- b. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- c. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- d. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- e. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Test Setup:



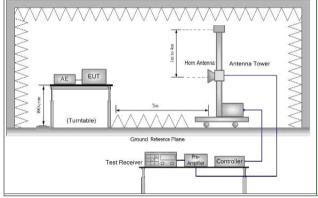


Figure 1. 30MHz to 1GHz

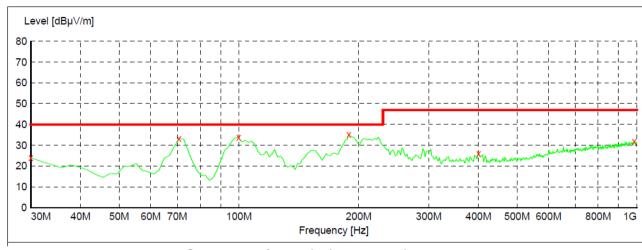
Figure 2. Above 1 GHz

Instruments Used:	Refer to section 4.10 for details				
Test Mode:	Mode a: Connect EUT and PC, exchanging data with SD card.				
	Mode b: Connect EUT and PC , keep EUT playing video with PC connected through HDMI port.				
	Mode c: Charging by PC +Keep EUT taking video and photos.				
	Mode d: Charging by PC +Keep EUT browsing video and photos.				
Final Test Mode:	Pretest the EUT at different test mode and found the "mode a" which is worst case, the test worst case is recorded in the report.				
Test Results:	Pass				



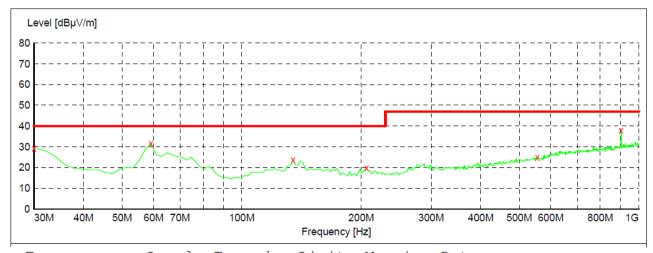
Peak value: 30MHz~1GHz

Horizontal



Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.
30.000000	24.00	21.1	40.0	16.0	-PK-
70.740000	33.20	8.4	40.0	6.8	-PK-
99.840000	33.80	11.5	40.0	6.2	-PK-
189.080000	35.10	13.4	40.0	4.9	-PK-
400.540000	25.90	18.1	47.0	21.1	-PK-
986.420000	31.90	27.1	47.0	15.1	-PK-

Vertical



Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.
30.000000 59.100000 134.760000 206.540000 555.740000 903.000000	29.30 31.70 23.60 19.70 24.90 38.00	21.1 8.3 14.8 14.3 21.1 26.1	40.0 40.0 40.0 40.0 47.0	10.7 8.3 16.4 20.3 22.1 9.0	-PK- -PK- -PK- -PK- -PK-
500.00000	00.00	20.1	1,.0		



Above 1G:

Horizontal

Frequency (MHz)	Level (dBµV/m)	Correct Factor (dB)	Limit ((dBµV/m)	Margin (dB)	Detector
1330.0000	13.80	-11.00	74	60.20	PK
1810.0000	24.30	-6.80	74	49.70	PK
1820.0000	25.10	-6.80	74	48.90	PK
3170.0000	29.40	2.70	74	44.60	PK
4050.0000	34.90	8.10	74	39.10	PK
5730.0000	35.70	9.50	74	38.30	PK
1310.0000	1.20	-11.00	54	52.80	AV
1810.0000	10.00	-6.80	54	44.00	AV
1820.0000	13.00	-6.80	54	41.00	AV
3130.0000	17.40	2.50	54	36.60	AV
4030.0000	22.30	8.10	54	31.70	AV
5730.0000	24.00	9.50	54	30.00	AV

Vertical

Frequency (MHz)	Level (dBµV/m)	Correct Factor (dB)	Limit ((dBµV/m)	Margin (dB)	Detector
1830.0000	25.50	-6.60	74	48.50	PK
2020.0000	27.00	-5.40	74	47.00	PK
2410.0000	28.30	-2.50	74	45.70	PK
3250.0000	30.20	3.00	74	43.80	PK
3990.0000	34.90	8.00	74	39.10	PK
5620.0000	36.50	9.60	74	37.50	PK
1320.0000	1.30	-11.00	54	52.70	AV
1810.0000	9.90	-6.80	54	44.10	AV
2410.0000	17.10	-6.80	54	36.90	AV
3280.0000	17.40	-2.50	54	36.60	AV
4010.0000	22.50	8.10	54	31.50	AV
5730.0000	24.10	9.50	54	29.90	AV

Remark:

The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

Final Test Level = Receiver Reading + Antenna Factor + Cable Factor - Preamplifier Factor The test range is from 1 GHz to 10 GHz, only the worst six points were recorded in the report.



6 Photographs - EUT Test Setup

6.1 Conducted Emission



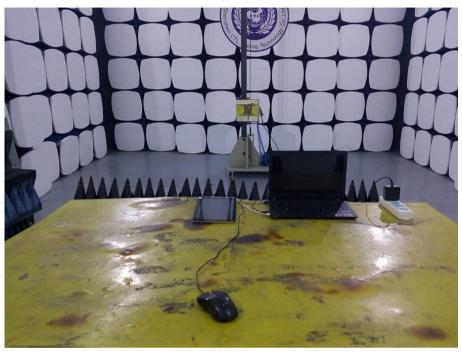
6.2 Radiatd Emission

30MHz~1GHz:





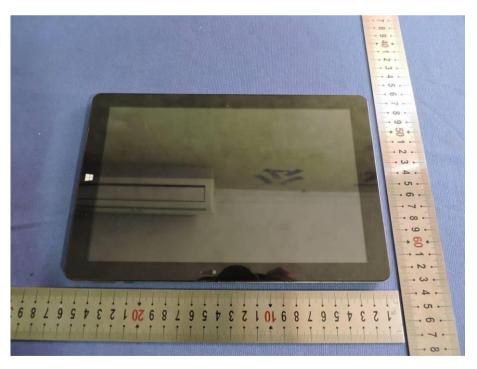
1GHz~10GHz:





7 Photographs of EUT Constructional Details











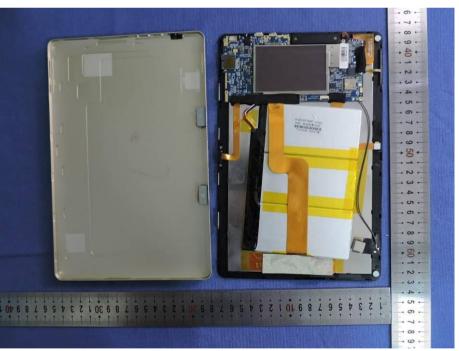






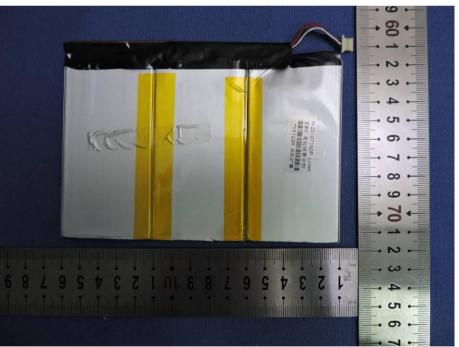




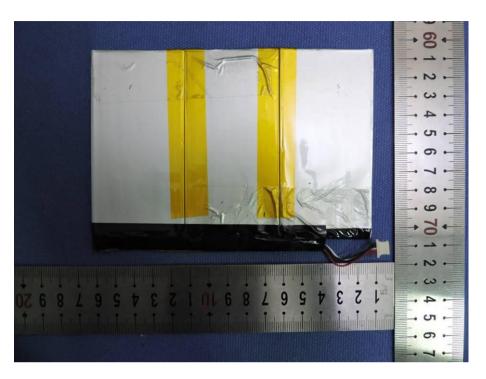


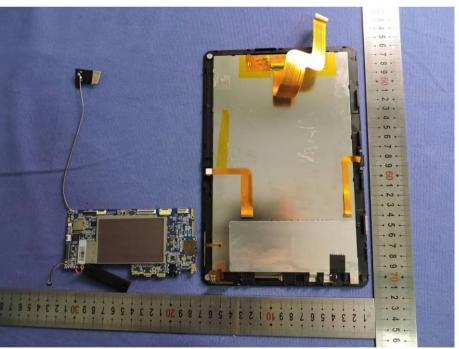




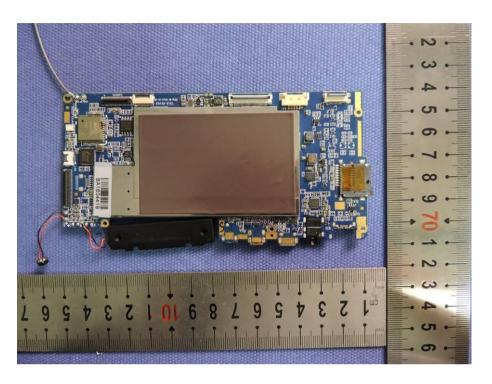


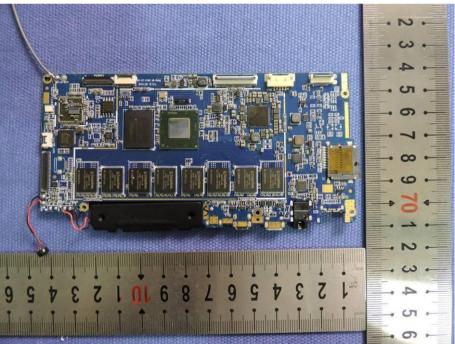


















END OF THE REPORT